

<b>Notice of References Cited</b>	Application/Control No. 10/615,895	Applicant(s)/Patent Under Reexamination JONES ET AL.	
	Examiner Yahveh Comas	Art Unit 2834	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,197,475	04-1980	Ban et al.	310/266
	B	US-5,723,933	03-1998	Grundl et al.	310/266
	C	US-4,665,331	05-1987	Sudo et al.	310/184
	D	US-6,570,273	05-2003	Hazelton, Andrew J.	310/12
	E	US-5,493,157	02-1996	Nakamura, Nobuaki	310/208
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 04058747 A	02-1992	Japan	NAKATANI et al.	H02K 15/04
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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